# Improved response characteristics of SnO<sub>2</sub> film based NO<sub>2</sub> gas sensor with nanoscaled metal oxide catalysts

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## Abstract:

Gas sensor structure based on rf sputtered  $SnO_2$  thin film is found to be highly sensitive  $(1.4x10^4)$  towards 100 ppm  $NO_2$  gas, but with slow response (~4min.) and recovery (~33min.) times. To improve the response and recovery speeds of the sensor, different catalysts (WO<sub>3</sub>, TeO<sub>2</sub>, Al<sub>2</sub>O<sub>3</sub>, NiO, CuO and In<sub>2</sub>O<sub>3</sub>) in the form of nanoclusters have been deposited over  $SnO_2$  surface and their effect towards sensing response characteristics of  $NO_2$  gas has been studied. Amongst all the catalysts  $WO_3$  nanoclusters are found to be yielding a high response (5.1x10<sup>4</sup>) for low concentration of  $NO_2$  gas at a low operating temperature of 100°C with a fast response and recovery times of 67sec and 17 min respectively.

Key words: Tin oxide, NO2 gas, Semiconductor, sensor, sputtering

## Introduction

Gas sensors based on semiconducting metal oxides have attracted the attention environmentalist and many others. Now a days, air pollution by nitrogen oxides (NO<sub>x</sub>), mainly NO and NO<sub>2</sub>, is becoming an important environmental issue. NO2 associated with other pollutants like volatile organic compounds (VOC) is responsible for the formation of ozone in lower atmosphere, smog in urban areas and also chemical reaction of NO2 gas with water vapour causes acid rain [1]. Therefore, as a first step, the development of a NO<sub>2</sub> gas sensor for environmental monitoring has become a necessary task. Among а semiconducting metal oxides, tin oxide (SnO<sub>2</sub>) is the most preferred material for gas sensor application because of its enhanced ability to adsorb oxygen on its surface and thus is highly sensitive towards many toxic and harmful gases [2]. However, requirement of lower operating temperature (< 200 °C) is the major objective. Currently, worldwide efforts are towards the development of inexpensive, compact and maintenance free NO2 gas sensors exhibiting higher response at low operating temperature. Pure SnO<sub>2</sub> is sensitive to many gases, and some degree of selectivity can be conferred by the use of appropriate materials and additives and/or the careful choice of working temperatures [3]. There are few reports on the detection of NOx gas using semiconducting metal oxide thin films of SnO<sub>2</sub> and SnO<sub>2</sub> doped

with suitable metal/metal oxide catalysts but the operating temperatures are reported to be quite high [4,5,6] and a systematic comparison of different catalysts for  $NO_2$  gas detection is missing. In the present work, an effort has been to study the effect of different catalysts in reducing the operating temperature of  $SnO_2$  based sensor structure along with improving the rate of adsorption and desorption of target gas on the sensor surface.

## **Experimental**

Tin oxide thin films were deposited using RF diode sputtering technique on Pt inter digital electrodes (IDEs) patterned corning glass substrates using a metallic tin target (99.999% pure) in Ar + O<sub>2</sub> gas ambient. The SnO<sub>2</sub> film of 430 nm was deposited at an optimized sputtering pressure of 16 m Torr in reactive ambient of 30% oxygen and 70% argon gas in the sputtering chamber [2]. The target to substrate distance was kept fixed at 7.5 cm and a power of 150Watt was supplied to the target. The ultrathin (thickness 8-16 nm) metal oxide catalysts of WO<sub>3</sub>, TeO<sub>2</sub>, Al<sub>2</sub>O<sub>3</sub>, NiO, CuO and In<sub>2</sub>O<sub>3</sub> were loaded in the form of nanoclusters on the surface of the sensing SnO2 layer using a shadow mask (600 µm pore size). The TeO<sub>2</sub> and NiO catalysts were deposited by RF sputtering using their respective metal targets in Ar + O<sub>2</sub> gas ambient, whereas WO<sub>3</sub> and CuO catalysts were deposited using Pulsed Laser Deposition technique. Nanoclusters of Al<sub>2</sub>O<sub>3</sub> and  $In_2O_3$  were fabricated over  $SnO_2$  thin films by depositing nano-thin Aluminum and Indium thin films using E-beam evaporation technique followed by annealing in oxygen environment at  $300^{\circ}\text{C}$  for 3 hours. All the prepared sensor structures were stabilized by annealing them in air at  $300^{\circ}\text{C}$  for 2 hours. Crystalline structure of the deposited  $SnO_2$  film was studied using X-Ray diffractometer (Bruker D8 Discover). Scanning electron microscope (SEM) (Zeiss Ultra Plus) was employed to examine the surface morphology of the sensor structures. A Double Beam UV-Visible Spectrophotometer (Perkin Elmer, Lambda 35) was used to study the optical properties of  $SnO_2$  thin film.

Gas sensing characteristics were performed in the specially designed Gas sensor test rig (GSTR). The GSTR was used with a glass bell jar to serve the twin purposes of mixing of target gas with the atmospheric gas and as the test chamber. The gas to be sensed (10 ppm NO<sub>2</sub>) was introduced in the bell jar with calibrated leaks using needle valves. Changes in the resistance values of sensor structure on interaction with the target NO<sub>2</sub> gas were recorded using a data acquisition system consisting of a digital multi-meter (DMM model: Keithley 2700) interfaced with a computer. This way the fast changing resistance values were logged on the computer every second.

 $NO_2$  is an oxidizing gas and the sensor response for the same is defined as

$$S = \frac{R_g - R_a}{R_a} \tag{1}$$

Where,  $R_a$  and  $R_g$  are the resistances of the sensor element in the presence of atmospheric air and target gas respectively.

## **Results and Discussions**

The as deposited SnO<sub>2</sub> film was found to be smooth, transparent and strongly adherent to the substrate surface. The as grown film was amorphous nature which became in polycrystalline when annealed at 300 °C for 3 hrs in air. Figure 1 shows the XRD pattern of annealed SnO<sub>2</sub> film deposited at 16 mTorr sputtering pressure. Broad and well defined reflections corresponding to (110), (101) and (211) planes of  $SnO_2$  were observed at  $2\theta$ =  $26.54^{\circ}$ ,  $34.1^{\circ}$  and  $51.54^{\circ}$  respectively which are in good agreement to the reported values for rutile structure [7]. The crystallite size of annealed SnO2 thin film was evaluated to be 10nm by fitting the FWHM of (110) XRD reflection using Scherrer's formula.

When the XRD pattern of SnO<sub>2</sub> thin film loaded with various catalysts was carried out, no peak

corresponding to any other metal oxide catalyst was observed. This may be due the very low thickness (8 to 18 nm) of metal oxide catalysts considered in the present work. Inset of figure 1 shows a low resolution SEM image of  $WO_3$  nanoclsuters loaded over  $SnO_2$  thin film. Smooth circular structures of catalyst on the surface of  $SnO_2$  film can be easily seen confirming the presence of thin catalyst clusters on the surface of  $SnO_2$  thin film.

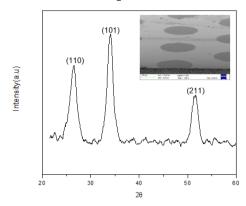


Figure 1: X-ray diffractogram of the SnO<sub>2</sub> thin film annealed in air at 300°C. Inset: SEM image of WO<sub>3</sub> nanoclusters loaded over SnO<sub>2</sub> thin film

A transmittance spectrum of the SnO<sub>2</sub> thin film has also been studied which shows that the SnO<sub>2</sub> thin film exhibits a high transmission (> 80%) in the visible region with well defined interference fringe pattern and show a sharp fundamental absorption edge at around 340 nm. The presence of well defined interference fringes pattern in the optical transmittance spectra indicates the growth of good quality SnO<sub>2</sub> thin films free from any type of inhomogenity. The value of optical bandgap (E<sub>0</sub>) was estimated from the Taue plot (linear portion of the plot between  $(\alpha h u)^2$  with photon energy (hu) where,  $\alpha$  is absorption coefficient and u is the optical frequency) and was found to be 3.8 eV which is close to the reported value (3.4 eV to 4.0 eV) for SnO<sub>2</sub> thin film by other workers [8].

Figure 2 shows the variation in sensor response with temperature for pure SnO2 thin film and loaded SnO<sub>2</sub> thin films with different nanoclustered metal oxide catalysts (WO<sub>3</sub>, TeO<sub>2</sub>, Al<sub>2</sub>O<sub>3</sub>, CuO, In<sub>2</sub>O<sub>3</sub>, NiO) towards 10 ppm NO<sub>2</sub> gas. It could be observed from figure 2 that for all the sensor structure, with increasing the temperature. the sensor response increases, attains a maxima at a temperature called the operating temperature and then reduces with further increase in temperature. It may be seen that the incorporation of WO<sub>3</sub> and TeO<sub>2</sub> catalysts, improves the sensing response, Al<sub>2</sub>O<sub>3</sub> gives almost similar response and other catalysts reduce the sensor response compared to the pure SnO<sub>2</sub> thin film based sensor structure. There is a slight reduction in the operating temperature also when TeO<sub>2</sub> (90°C) and CuO (80°C) catalysts are incorporated with the SnO<sub>2</sub> sensing layer. Sensing response characteristics (response, response time, recovery time, operating temperature) of all the sensor structures i.e. pure SnO<sub>2</sub> and SnO<sub>2</sub> thin film loaded with metal oxide catalysts, are summarized in table I. It may be seen from Table I that the pure SnO<sub>2</sub> thin film based sensor structure shows the maximum response of 1.4 x10<sup>4</sup> at an operating temperature of 100 °C but with poor response and recovery times of 4 mins and 33 mins. respectively. Sensor structures with WO<sub>3</sub>, TeO<sub>2</sub> and Al<sub>2</sub>O<sub>3</sub> nanoclusters show the improved gas sensing response with faster response and recovery times. However, with the incorporation of NiO, CuO and In<sub>2</sub>O<sub>3</sub> catalysts the sensor response reduces, but the response and recovery times are improved (Table 1).

A maximum response of 5.1x10<sup>4</sup> is obtained for the sensor structure loaded with WO<sub>3</sub> nanoclusters at a comparatively low operating temperature of 100 °C with fast response and recovery speeds of 67 sec and 17 min. respectively. With the incorporation of TeO2 the maximum sensor response is obtained at an operating temperature of 90 °C with response and recovery times of 1.6 min and 16 min respectively. This may be attributed to the junction formed modulation of semiconducting SnO2 and catalyst interface on interaction with the target NO<sub>2</sub> gas (10 ppm) along with the possible spill over mechanism.

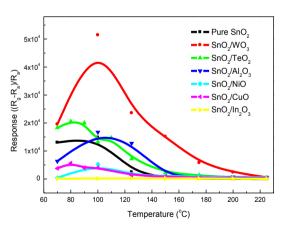


Fig 2: Variation in response with temperature of SnO<sub>2</sub> sensors covered with various catalysts

Figures 3 and 4 show the variation of sensor resistance in presence of atmospheric air  $(R_a)$  and 10 ppm of  $NO_2$  gas  $(R_g)$  respectively with temperature for all the sensor structures. It can

be observed from figure 3 that pure SnO2 and SnO<sub>2</sub> loaded with WO<sub>3</sub> catalyst shows the minimum starting resistance which increases for other catalysts. CuO and NiO nanoclusters loaded sensor structures show a high starting resistance of 49 k $\Omega$  and 23 k $\Omega$  respectively. The higher resistance values are attributed to the formation of depletion width at the catalystinterface. With increasing temperature, the sensor resistance of all the sensor structures decreases and is accordance with the semiconducting nature of the sensing lavers.

When 10 ppm of NO2 gas was exposed to different sensor structures, sensor resistance increases drastically from Ra to Ra due to the oxidizing nature of NO2 gas. Sensor structures exhibiting low initial resistance (R<sub>2</sub>) and high resistance in the presence of target gas (R<sub>g</sub>) result in higher sensing response. Sensor structure with TeO2 and CuO shows the maximum increase in  $R_{g}$  (Figure 4) but due to higher initial value of resistance R<sub>a</sub> (Figure 3) the sensor response does not show appreciable enhancement (Table I). On the other hand, for WO<sub>3</sub> catalyst the value of R<sub>q</sub> does not increase much but due to lower Ra value, it shows the maximum sensor response as compared to metal oxides catalysts. Thus the other cumulative values of Ra and Ra decides the maximum sensor response.

Sensor	Response	Response	Recovery	Operating
Structure		time	time	temperature
Pure SnO <sub>2</sub>	1.4x10⁴	4 min	33 min	100 °C
SnO <sub>2</sub> /WO <sub>3</sub>	5.1x10⁴	67 sec	17 min	100 °C
SnO <sub>2</sub> /TeO <sub>2</sub>	2.0x10⁴	1.6 min	16 min	90 °C
SnO <sub>2</sub> /Al <sub>2</sub> O <sub>3</sub>	1.6x10⁴	1.5 min	20 min	100 °C
SnO <sub>2</sub> /NiO	5.2x10 <sup>3</sup>	1.4 min	22 min	100 °C
SnO <sub>2</sub> /CuO	5.6x10 <sup>3</sup>	1.2 min	4.2 min	80 °C
SnO <sub>2</sub> /In <sub>2</sub> O <sub>3</sub>	1.6x10 <sup>2</sup>	6.7 min	6.8 min	100 °C

Tab. 1: Summarized sensing parameters obtained for various sensor structures

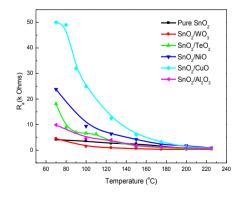


Fig 3: Variation in Resistance in presence of air with temperature of SnO<sub>2</sub> sensors covered with various catalysts

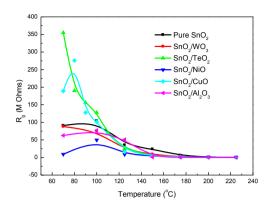


Fig 4: Variation in Resistance in presence of 10 ppm NO<sub>2</sub> gas with temperature of SnO<sub>2</sub> sensors covered with various catalysts

## Conclusion

The sensing response characteristics of the RF-sputtered  $SnO_2$  thin film sensor having metal oxide catalysts in the form of nanoclusters have been studied towards 10 ppm  $NO_2$  gas. The  $SnO_2$  thin film based sensor structure having  $WO_3$  catalyst exhibits enhanced response  $(5.4\times10^4)$  at a lower operating temperature of  $100\,^{\circ}C$ . The possible spillover of dissociated  $NO_2$  gas molecules leads to fast response and recovery times of 67 sec and 17 min respectively.

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